THIS SPEC IS OBSOLETE

Spec No: 38-04004

Spec Title: CY7C276 16K x 16 Reprogrammable PROM

Sunset Owner: P Indira (PCI)

Replaced by: None

CY7C276

16K x 16 Reprogrammable PROM

Features

- **0.8-micron CMOS for optimum speed/power**
- **High speed**
  - **—25-ns access time**
- **16-bit-wide words**
- **Three programmable chip selects**
- **Programmable output enable**
- **44-pin PLCC and 44-pin LCC packages**
- **100% reprogrammable in windowed packages**
- **TTL-compatible I/O**
- **Capable of withstanding greater than 2001V static discharge**

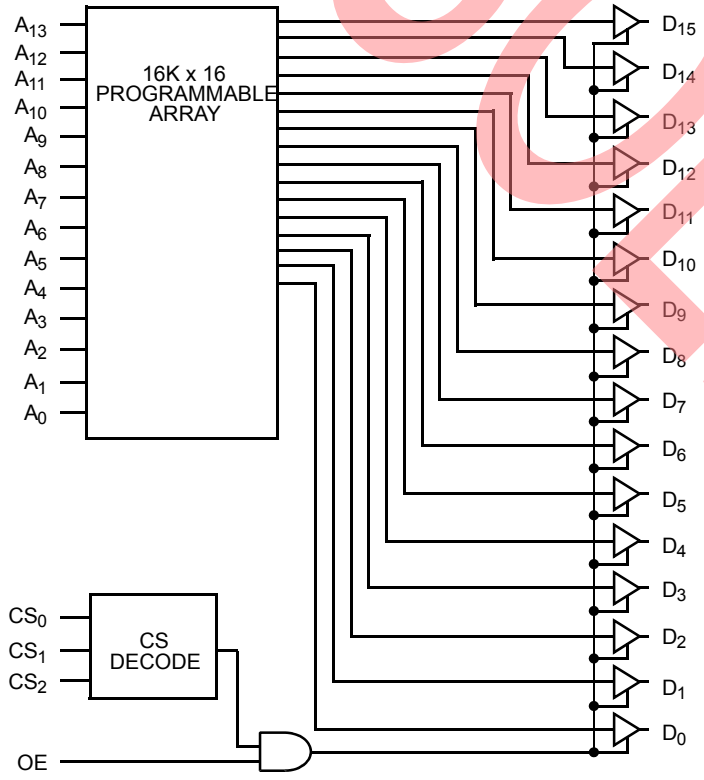
Functional Description

The CY7C276 is a high-performance 16K-word by 16-bit CMOS PROM. It is available in a 44-pin PLCC and a 44-pin LCC packages, and is 100% reprogrammable in windowed packages. The memory cells utilize proven EPROM floating gate technology and word-wide programming algorithms.

The CY7C276 allows the user to independently program the polarity of each chip select (CS_2–CS_0). This provides on-chip decoding of up to eight banks of PROM. The polarity of the asynchronous output enable pin (OE) is also programmable.

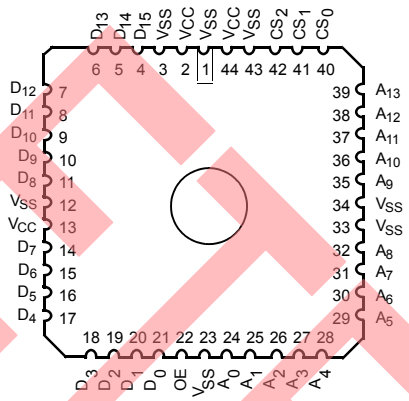
In order to read the CY7C276, all three chip selects must be active and OE must be asserted. The contents of the memory location addressed by the address lines (A_{13}–A_0) will become available on the output lines (D_{15}–D_0). The data will remain on the outputs until the address changes or the outputs are disabled.

Logic Block Diagram



Pin Configuration

LCC/PLCC/CLCC
Top View



Selection Guide

		CY7C276-25	CY7C276-30	Unit
Maximum Access Time		25	30	ns
Maximum Operating Current	Commercial	175	175	mA

Maximum Ratings[1]

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature ..... –65°C to+150°C

Ambient Temperature with Power Applied..... –55°C to+125°C

Supply Voltage to Ground Potential ..... –0.5V to+7.0V

DC Voltage Applied to Outputs in High Z State ..... –0.5V to+7.0V

DC Input Voltage..... –3.0V to +7.0V

DC Program Voltage 13.0V

UV Erasure..... 7258 Wsec/cm^2

Static Discharge Voltage..... >2001V (per MIL-STD-883, Method 3015)

Latch-Up Current..... >200 mA

Operating Range

Range	Ambient Temperature	V_{CC}
Commercial	0°C to +70°C	5V ±10%

Electrical Characteristics[2, 3]

Parameter	Description	Test Conditions		CY7C276-25 CY7C276-30 Min.	CY7C276-25 CY7C276-30 Max.	Unit
V_{OH}	Output HIGH Voltage	V_{CC} = Min., I_{OH} = –2.0 mA		2.4		V
V_{OL}	Output LOW Voltage	V_{CC} = Min., I_{OL} = 8.0 mA (6.0 mA Mil)			0.4	V
V_{IH}	Input HIGH Level	Guaranteed Input Logical HIGH Voltage for All Inputs		2.0	V_{CC}	V
V_{IL}	Input LOW Level	Guaranteed Input Logical LOW Voltage for All Inputs		–3.0	0.8	V
I_{IX}	Input Leakage Current	GND ≤ V_{IN} ≤ V_{CC}		–10	+10	µA
V_{CD}	Input Clamp Diode Voltage			Note 2		µA
I_{OZ}	Output Leakage Current	V_{CC} = Max., V_{OL} ≤ V_{OUT} ≤ V_{OH}, Output Disabled		–40	+40	µA
I_{OS}	Output Short Circuit Current	V_{CC} = Max., V_{OUT} = 0.0V[4]		–20	–90	mA
I_{CC}	Power Supply Current	V_{CC} = Max., I_{OUT} = 0.0 mA	Com'l		175	mA

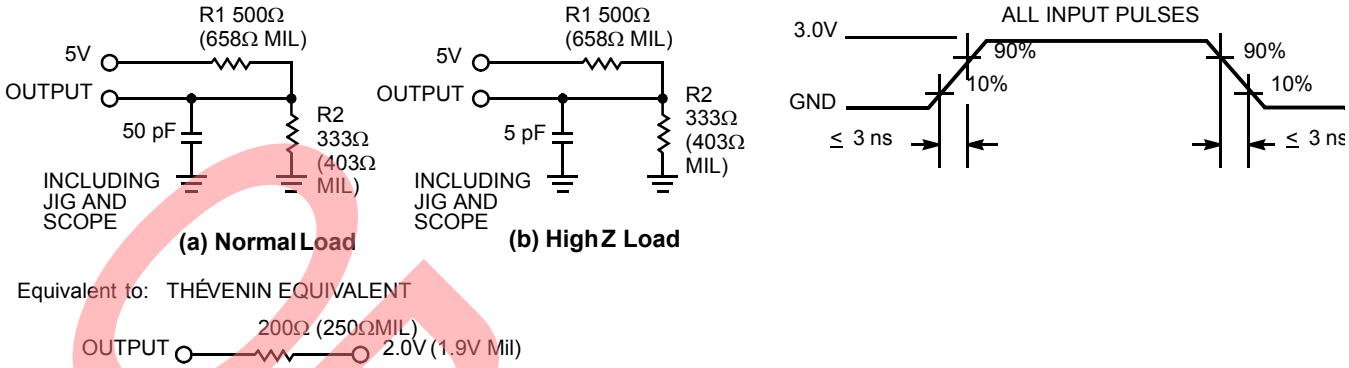
Capacitance[2]

Parameter	Description	Test Conditions	Max.	Unit
C_{IN}	Input Capacitance	T_A = 25°C, f = 1 MHz, V_{CC} = 5.0V	10	pF
C_{OUT}	Output Capacitance		10	pF

Notes:

1. The voltage on any input or I/O pin cannot exceed the power pin during power-up.
2. See Introduction to CMOS PROMs in this Data Book for general information on testing.
3. See the last page of this specification for Group A subgroup testing information.
4. For test purposes, not more than one output at a time should be shorted. Short circuit test duration should not exceed 30 seconds.

AC Test Loads and Waveforms



Switching Characteristics Over the Operating Range[2,3]

Parameter	Description	CY7C276-25		CY7C276-30		Unit
		Min.	Max.	Min.	Max.	
t_{AA}	Address to Output Data Valid		25		30	ns
t_{CSOV}	CS Active to Output Valid		13		15	ns
t_{CSOZ}	CS Inactive to High Z Output		13		15	ns
t_{OEV}	OE Active to Output Valid		11		12	ns
t_{OEZ}	OE Inactive to High Z Output		11		12	ns

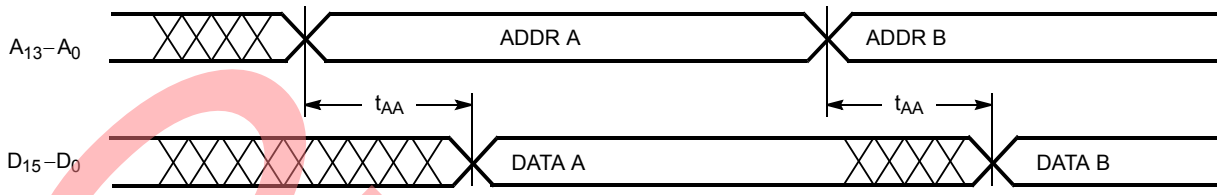
Erasure Characteristics

The recommended dose of ultraviolet light for erasure is a wavelength of 2537 Angstroms for a minimum dose (UV intensity multiplied by exposure time) of 25 Wsec/cm^2. For an ultraviolet lamp with a 12 mW/cm^2 power rating the exposure time would be approximately 35 minutes. The CY7C276 needs to be within 1 inch of the lamp during erasure. Permanent damage may result if the EPROM is exposed to high-intensity UV light for an extended period of time. 7258 Wsec/cm^2 is the recommended maximum dosage.

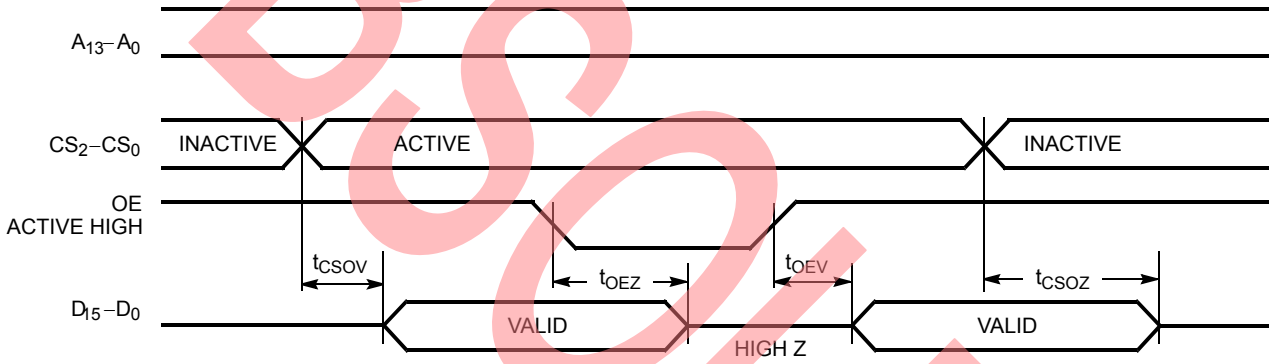
Wavelengths of light less than 4000 Angstroms begin to erase the CY7C276 in the windowed package. For this reason, an opaque label should be placed over the window if the EPROM is exposed to sunlight or fluorescent lighting for extended periods of time.

Switching Waveforms

Read Operation Timing Diagram [5]



Chip Select and Output Enable Timing Diagrams



Note:
5. CS_2 – CS_0, OE assumed active.

Architecture Configuration Bits

The CY7C276 has four user-programmable options in addition to the reprogrammable data array. For detailed programming information contact your local Cypress representative.

The programmable options determine the active polarity for the three chip selects (CS_2–CS_0) and OE. When these control bits are programmed with a 0 the inputs are active LOW. When these control bits are programmed with a 1 the inputs are active HIGH.

Programming Information

Programming support is available from Cypress as well as from a number of third-party software vendors. For detailed programming information, including a listing of software packages, please see the PROM Programming Information located at the end of this section. Programming algorithms can be obtained from any Cypress representative.

Table 1. Control Word for Architecture Configuration

Control Option	Control Word		Function
	Bit	Programmed Level	
OE	D_0	0 = Default 1 = Programmed	OE Active LOW OE Active HIGH
CS_0	D_{12}	0 = Default 1 = Programmed	CS_0 Active LOW CS_0 Active HIGH
CS_1	D_{13}	0 = Default 1 = Programmed	CS_1 Active LOW CS_1 Active HIGH
CS_2	D_{14}	0 = Default 1 = Programmed	CS_2 Active LOW CS_2 Active HIGH

Bit Map

Programmer Address (Hex)	RAM Data
0000	Data
.	.
.	.
.	.
3FFF	Data
4000	Control Word

Control Word (4000H)

D15 D0

X CS2 CS1 CS0 X X X X X X X X 1 X X OE

Table 2. Program Mode Table

Mode	V_{PP}	$\overline{PGM}$	$\overline{VFY}$	D_0–D_{15}
Program Inhibit	V_{PP}	V_{IHP}	V_{IHP}	High Z
Program Enable	V_{PP}	V_{ILP}	V_{IHP}	Data
Program Verify	V_{PP}	V_{IHP}	V_{ILP}	Data

Table 3. Configuration Mode Table

Mode	V_{PP}	$\overline{PGM}$	$\overline{VFY}$	A_2	D_0–D_{15}
Program Inhibit	V_{PP}	V_{IHP}	V_{IHP}	V_{PP}	High Z
Program Control Word	V_{PP}	V_{ILP}	V_{IHP}	V_{PP}	Control Word
Verify Control Word	V_{PP}	V_{IHP}	V_{ILP}	V_{PP}	Control Word

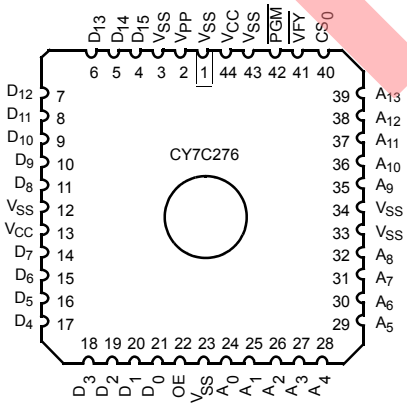
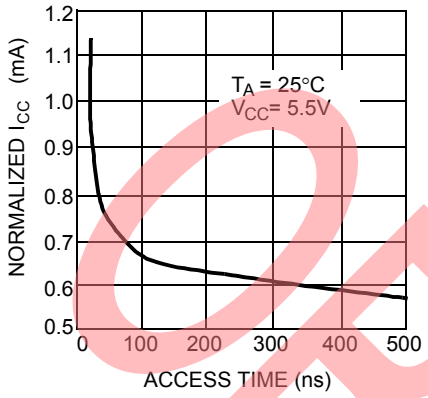


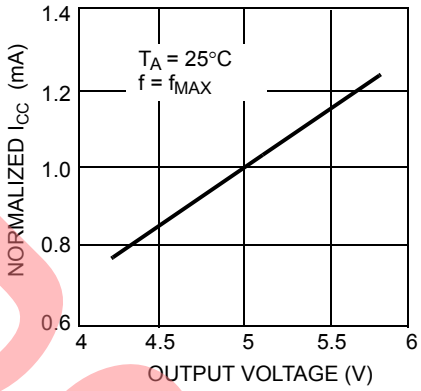
Figure 1. Programming Pinout

Typical DC and AC Characteristics

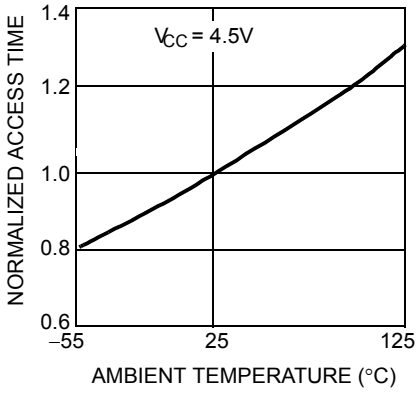
NORMALIZED I_{CC} vs. t_{CKA} CYCLE



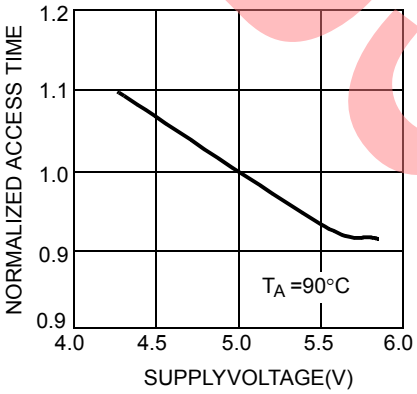
NORMALIZED I_{CC} vs. OUTPUT VOLTAGE



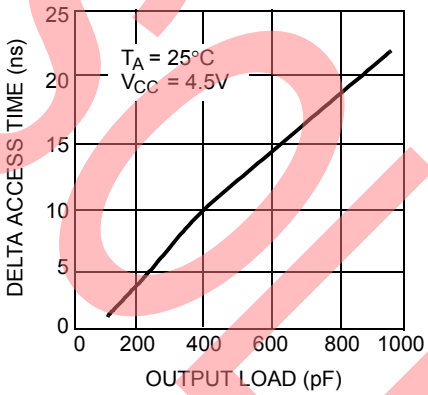
NORMALIZED t_{CKA} vs. TEMPERATURE



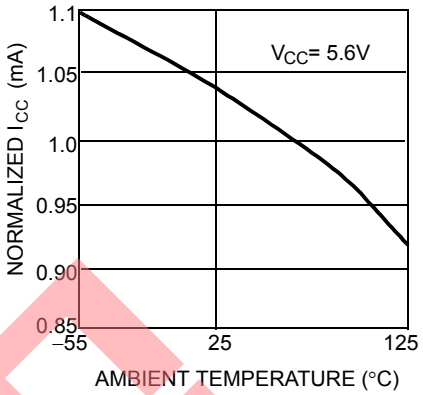
NORMALIZED t_{CKA} vs. SUPPLY VOLTAGE



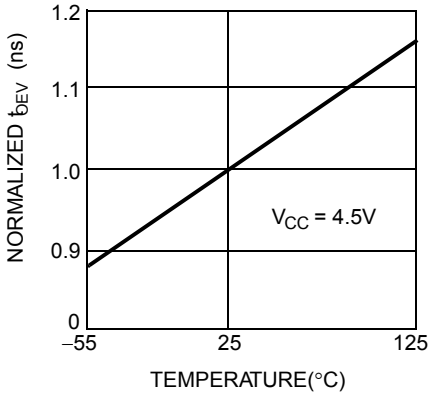
t_{CKA} CHANGE vs. OUTPUT LOADING



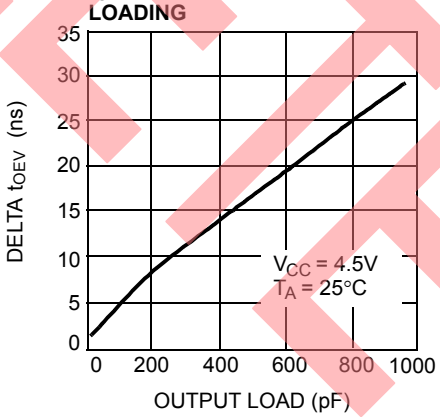
NORMALIZED I_{CC} vs. AMBIENT TEMPERATURE



NORMALIZED t_{OEV} vs. TEMPERATURE



t_{OEV} CHANGE vs. OUTPUT LOADING



Ordering Information

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
25	CY7C276-25HC	H67	44-Pin Windowed Leaded Chip Carrier	Commercial
	CY7C276-25JC	J67	44-Lead Plastic Leaded Chip Carrier	
30	CY7C276-30JC	J67	44-Lead Plastic Leaded Chip Carrier	Commercial

MILITARY SPECIFICATIONS
Group A Subgroup Testing

DC Characteristics

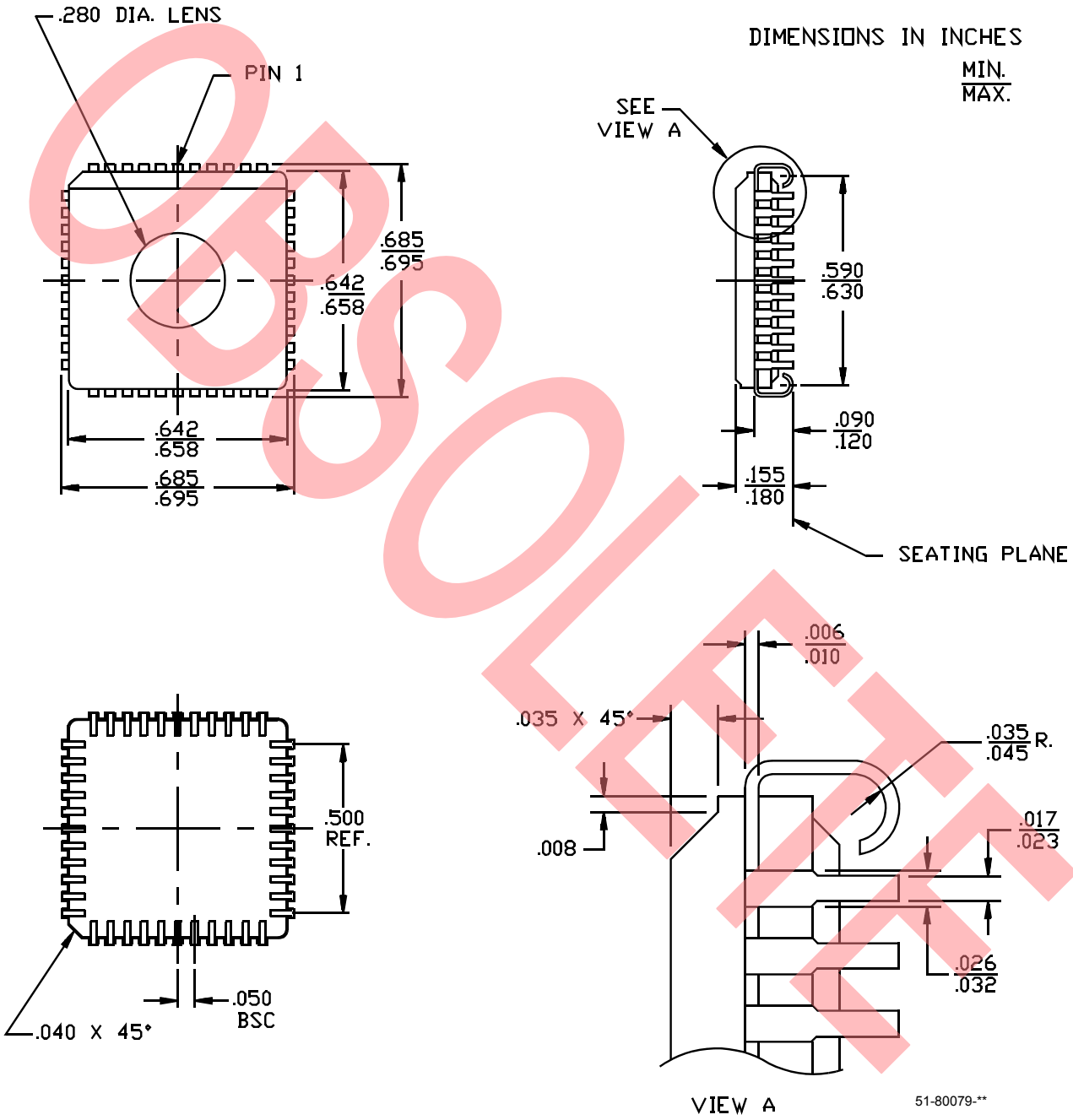
Parameter	Subgroups
V_{OH}	1, 2, 3
V_{OL}	1, 2, 3
V_{IH}	1, 2, 3
V_{IL}	1, 2, 3
I_{IX}	1, 2, 3
I_{OZ}	1, 2, 3
I_{CC}	1, 2, 3

Switching Characteristics

Parameter	Subgroups
t_{AA}	7, 8, 9, 10, 11
t_{CSOV}	7, 8, 9, 10, 11
t_{OEV}	7, 8, 9, 10, 11

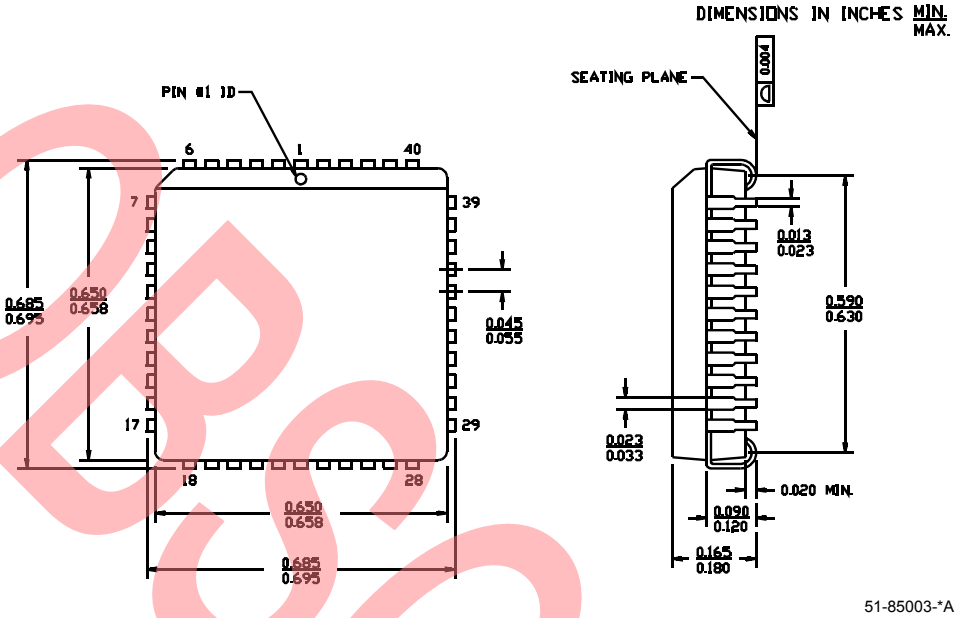
Package Diagrams

44-Pin Windowed Leaded Chip Carrier H67



Package Diagrams (continued)

44-Lead Plastic Leaded Chip Carrier J67



Document History Page

Document Title: CY7C276 16K x 16 Reprogrammable PROM Document Number: 38-04004				
REV.	**ECN NO.**	**Issue Date**	**Orig. of Change**	**Description of Change**
**	113860	03/06/02	DSG	Change from Spec number: 38-00183 to 38-04004
*A	118900	10/09/02	GBI	Update ordering information
*B	122245	12/27/02	RBI	Add power up requirements to Maximum Ratings information
*C	504720	See ECN	PCI	Obsolete Device. Datasheet to be removed from Cypress web and spec. system